S	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/585,793	SHIMA ET AL.	
Examiner ,	Art Unit	
Jennifer Y. Cho	1621	

	SEARCHED		
Class	Subclass	Date	Examiner
-			
	,		
	·		
		-	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
· · · · · · · · · · · · · · · · · · ·			
,			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
STIC Search	5/11/2007	BS
Inventor Search	5/11/2007	BS
East Search	5/17/2007	JC
Inventor Search	5/17/2007	JC
STN Search	5/17/2007	JC
562/532 and 562/577 text search	5/17/2007	JC